

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Young Hoon Kwark

Examiner: Emily Y. Chan

Serial No: 10/769,115

Group Art Unit: 2829

Filed: January 30, 2004

Docket: YOR920030625US1 (163-27)

For: CONTACTLESS CIRCUIT TESTING FOR ADAPTIVE WAFER PROCESSING

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AMENDMENT UNDER 37 C.F.R. §1.116

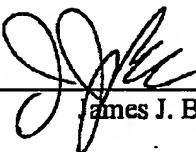
This is a response to the Office Action mailed October 10, 2006. Please amend  
the above-identified application as follows:

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CERTIFICATE OF MAILING 37 C.F.R. §1.8(a)

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James J. Bitetto